

Notice of References Cited	Application/Control No. 10/743,172	Applicant(s)/Patent Under Reexamination KAWASE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0224231	11-2004	Fujimoto et al.	429/232
*	B	US-6,242,132	06-2001	Neudecker et al.	429/218.1
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 11-135115	05-1999	Japan	Akagi et al.	H01M 4/36
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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